

Search Notes

Application/Control No.

10/743,190

Examiner

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Applicant(s)/Patent under
Reexamination

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Art Unit

2861

SEARCHED

Class	Subclass	Date	Examiner
347	214	3/1/2006	HHT
400	208.1,242	3/1/2006	HHT
400	246	3/1/2006	HHT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
Interference search_see search history printout		3/1/2006	HHT

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST text search (USPAT;US_PGPUB;JPO;EPO;DER WENT;IBM-TDB)_see search history printout	3/1/2006	HHT